

## SERIAL NO.

10/687.620

APPLICANT

NAKAYAMA

FILING DATE

GROUP

October 20, 2003

2814

## U.S. PATENT DOCUMENTS

\*EXAMINER

FILING DATE

INITIAL

DOCUMENT NUMBER

DATE \_\_\_\_\_

NAME \_\_\_\_\_

CLAS

SUBCLASS

F AP PROPRIATE

## FOREIGN PATENT DOCUMENTS

TRANSLATION

DOCUMENT

DATE \_\_\_\_\_

COUNTRY

CLAS

SUBCLASS

YES

NC

## OTHER DOCUMENTS (including Author, Title, Date, Pertinent pages, etc.)

Kittl et al, "Time-Resolved Temperature Measurements During Rapid Solidification of Si-As Alloys Induced by Pulsed-Laser Melting", J. Appl. Phys., 78 (8); 16 April 1993, pp. 3725-3733

Ceradyne, Inc., "Ceralloy® Silicon Nitride Ceramics Property Comparison"

\*Examiner

~~/Long Pham/ (10/23/2008)~~

Date Considered

Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to application.

Form PTO-FB-A820 (Also PTO-1449)

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /L.P./

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